
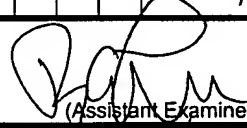
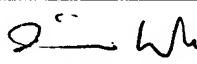



<b>Issue Classification</b> 	Application/C ntr I No.	Applicant(s)/Pat nt under Re xamination	
	10/694,171	NAKAO, HAJIME	
	Examiner	Art Unit	
	Rip A. Lee	1713	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
524		376			524	385	291	317	320	
INTERNATIONAL CLASSIFICATION					430	270.1				
C	0	8	K	5/06						
C	0	8	K	5/05						
G	0	3	C	1/76						
				/						
				/						

 (Assistant Examiner)		JUNE 26, 2006 (Date)		 DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner)		6/26/06 (Date)		Total Claims Allowed: 12	
 (Legal Instruments Examiner)		6/27/06 (Date)				O.G. Print Claim(s) 1		O.G. Print Fig. ---	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47							
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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2	2		32		62		92		122		152		182
3	3		33		63		93		123		153		183
4	4		34		64		94		124		154		184
5	5		35		65		95		125		155		185
6	6		36		66		96		126		156		186
	7		37		67		97		127		157		187
7	8		38		68		98		128		158		188
8	9		39		69		99		129		159		189
9	10		40		70		100		130		160		190
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	30		60		90		120		150		180		210